



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



General Description

- Latest AlphaIGBT (α IGBT) technology
- 650V breakdown voltage
- Very fast and soft recovery freewheeling diode
- High efficient turn-on di/dt controllability
- Low VCE(SAT) enables high efficiencies
- Low turn-off switching loss and softness
- Very good EMI behavior
- High short-circuit ruggedness

Applications

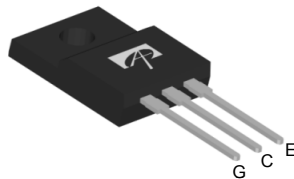
- Motor Drives
- Sewing Machines
- Home Appliances
- Fan, Pumps, Vacuum Cleaner
- Other Hard Switching Applications

Product Summary

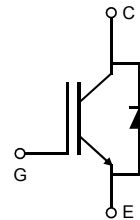
V_{CE}	650V
I_C ($T_C=100^\circ\text{C}$)	15A
$V_{CE(sat)}$ ($T_J=25^\circ\text{C}$)	1.7V



TO-220F



AOTF15B65M1



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOTF15B65M1	TO220F	Tube	1000

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	AOTF15B65M1	Units
Collector-Emitter Voltage	V_{CE}	650	V
Gate-Emitter Voltage	V_{GE}	± 30	V
Continuous Collector Current	I_C	$T_C=25^\circ\text{C}$	30 ²⁾
		$T_C=100^\circ\text{C}$	15 ²⁾
Pulsed Collector Current, Limited by T_{Jmax}	I_{CM}	45	A
Turn off SOA, $V_{CE} \leq 650\text{V}$, Limited by T_{Jmax}	I_{LM}	45	A
Continuous Diode Forward Current	I_F	$T_C=25^\circ\text{C}$	30 ²⁾
		$T_C=100^\circ\text{C}$	15 ²⁾
Diode Pulsed Current, Limited by T_{Jmax}	I_{FM}	45	A
Short circuit withstanding time ¹⁾ $V_{GE} = 15\text{V}$, $V_{CC} \leq 400\text{V}$, $T_J \leq 150^\circ\text{C}$	t_{SC}	5	μs
Power Dissipation	P_D	$T_C=25^\circ\text{C}$	36
		$T_C=100^\circ\text{C}$	14
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^\circ\text{C}$
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	T_L	300	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	AOTF15B65M1	Units
Maximum Junction-to-Ambient	$R_{\theta JA}$	65	$^\circ\text{C/W}$
Maximum IGBT Junction-to-Case	$R_{\theta JC}$	3.5	$^\circ\text{C/W}$
Maximum Diode Junction-to-Case	$R_{\theta JC}$	5	$^\circ\text{C/W}$

1) Allowed number of short circuits: <1000; time between short circuits: >1s.

2) TO220F I_C Follow TO220/TO263.

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units	
STATIC PARAMETERS							
BV_{CES}	Collector-Emitter Breakdown Voltage	$I_C=1mA, V_{GE}=0V, T_J=25^\circ C$	650	-	-	V	
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$V_{GE}=15V, I_C=15A$	$T_J=25^\circ C$	-	1.7	2.15	V
			$T_J=125^\circ C$	-	2.03	-	
			$T_J=150^\circ C$	-	2.12	-	
V_F	Diode Forward Voltage	$V_{GE}=0V, I_C=15A$	$T_J=25^\circ C$	-	1.77	2.25	V
			$T_J=125^\circ C$	-	1.82	-	
			$T_J=150^\circ C$	-	1.79	-	
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$V_{CE}=5V, I_C=1mA$	-	5.1	-	V	
I_{CES}	Zero Gate Voltage Collector Current	$V_{CE}=650V, V_{GE}=0V$	$T_J=25^\circ C$	-	-	10	μA
			$T_J=125^\circ C$	-	-	500	
			$T_J=150^\circ C$	-	-	1000	
I_{GES}	Gate-Emitter leakage current	$V_{CE}=0V, V_{GE}=\pm 30V$	-	-	±100	nA	
g_{FS}	Forward Transconductance	$V_{CE}=20V, I_C=15A$	-	11	-	S	
DYNAMIC PARAMETERS							
C_{ies}	Input Capacitance	$V_{GE}=0V, V_{CC}=25V, f=1MHz$	-	923	-	pF	
C_{oes}	Output Capacitance		-	96	-	pF	
C_{res}	Reverse Transfer Capacitance		-	33	-	pF	
Q_g	Total Gate Charge	$V_{GE}=15V, V_{CC}=520V, I_C=15A$	-	32	-	nC	
Q_{ge}	Gate to Emitter Charge		-	7.8	-	nC	
Q_{gc}	Gate to Collector Charge		-	15	-	nC	
$I_{C(SC)}$	Short circuit collector current	$V_{GE}=15V, V_{CC}=400V,$ $t_{sc} \leq 5\mu s, T_J \leq 150^\circ C$	-	90	-	A	
R_g	Gate resistance	$V_{GE}=0V, V_{CC}=0V, f=1MHz$	-	6.7	-	Ω	
SWITCHING PARAMETERS, (Load Inductive, T_J=25°C)							
$t_{D(on)}$	Turn-On Delay Time	$T_J=25^\circ C$ $V_{GE}=15V, V_{CC}=400V, I_C=15A,$ $R_G=20\Omega$	-	15	-	ns	
t_r	Turn-On Rise Time		-	18	-	ns	
$t_{D(off)}$	Turn-Off Delay Time		-	94	-	ns	
t_f	Turn-Off Fall Time		-	14	-	ns	
E_{on}	Turn-On Energy		-	0.29	-	mJ	
E_{off}	Turn-Off Energy		-	0.2	-	mJ	
E_{total}	Total Switching Energy		-	0.49	-	mJ	
t_{rr}	Diode Reverse Recovery Time		$T_J=25^\circ C$	-	317	-	ns
Q_{rr}	Diode Reverse Recovery Charge		$I_F=15A, dl/dt=200A/\mu s, V_{CC}=400V$	-	0.7	-	μC
I_{rm}	Diode Peak Reverse Recovery Current			-	4.7	-	A
SWITCHING PARAMETERS, (Load Inductive, T_J=150°C)							
$t_{D(on)}$	Turn-On Delay Time	$T_J=150^\circ C$ $V_{GE}=15V, V_{CC}=400V, I_C=15A,$ $R_G=20\Omega$	-	14	-	ns	
t_r	Turn-On Rise Time		-	20	-	ns	
$t_{D(off)}$	Turn-Off Delay Time		-	111	-	ns	
t_f	Turn-Off Fall Time		-	24	-	ns	
E_{on}	Turn-On Energy		-	0.32	-	mJ	
E_{off}	Turn-Off Energy		-	0.34	-	mJ	
E_{total}	Total Switching Energy		-	0.66	-	mJ	
t_{rr}	Diode Reverse Recovery Time		$T_J=150^\circ C$	-	478	-	ns
Q_{rr}	Diode Reverse Recovery Charge		$I_F=15A, dl/dt=200A/\mu s, V_{CC}=400V$	-	1.1	-	μC
I_{rm}	Diode Peak Reverse Recovery Current			-	5.7	-	A

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

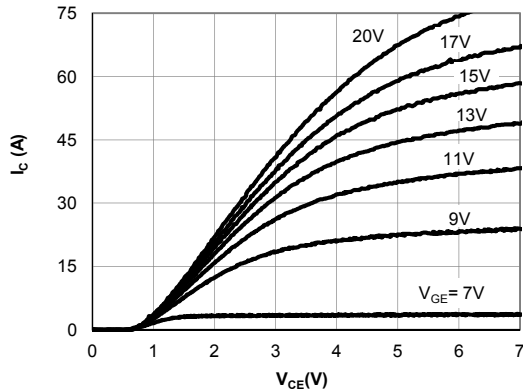


Figure 1: Output Characteristic
($T_j=25^{\circ}\text{C}$)

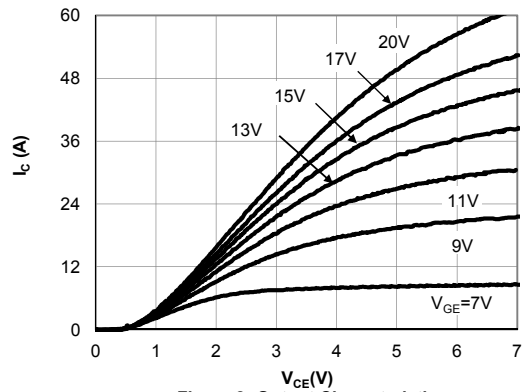


Figure 2: Output Characteristic
($T_j=150^{\circ}\text{C}$)

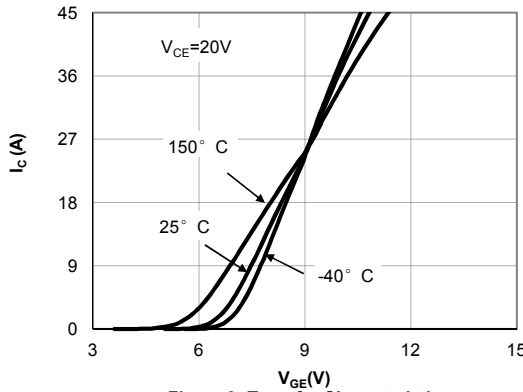


Figure 3: Transfer Characteristic

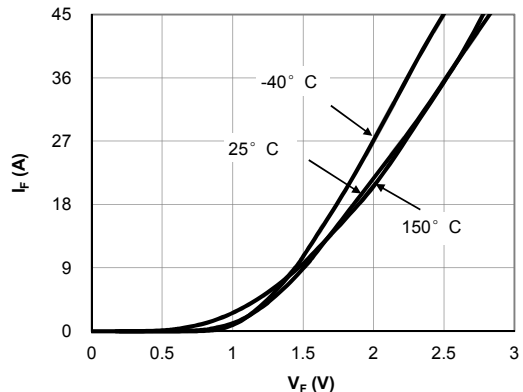


Figure 4: Diode Characteristic

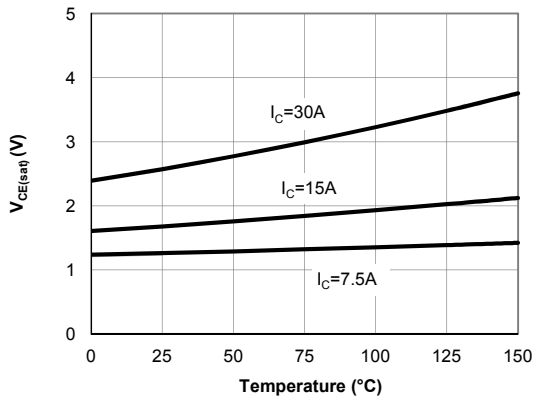


Figure 5: Collector-Emitter Saturation Voltage vs. Junction Temperature

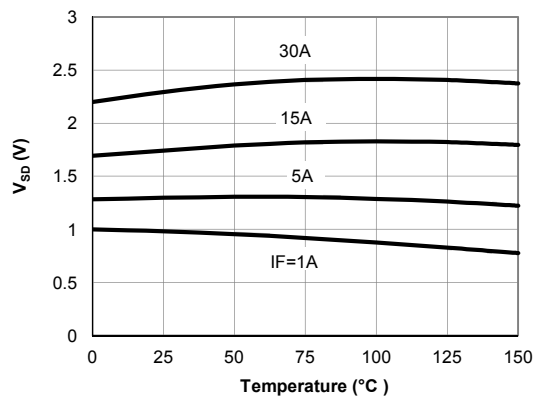


Figure 6: Diode Forward voltage vs. Junction Temperature

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

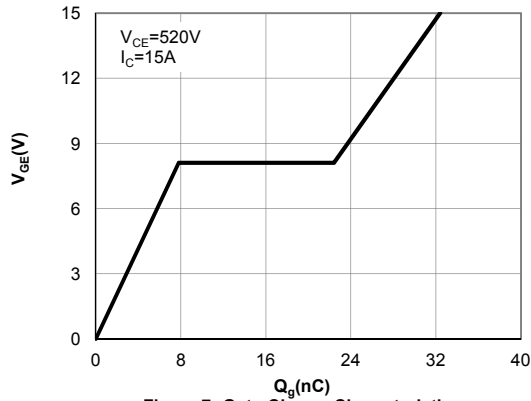


Figure 7: Gate-Charge Characteristics

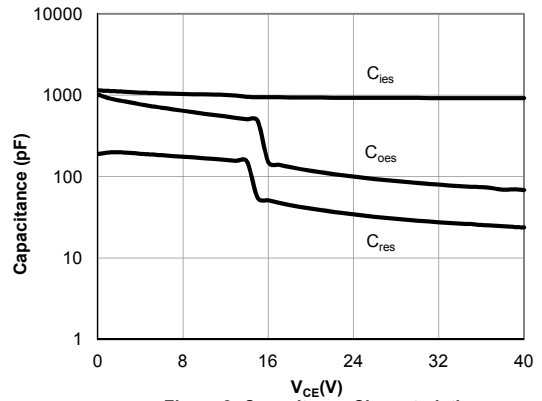


Figure 8: Capacitance Characteristic

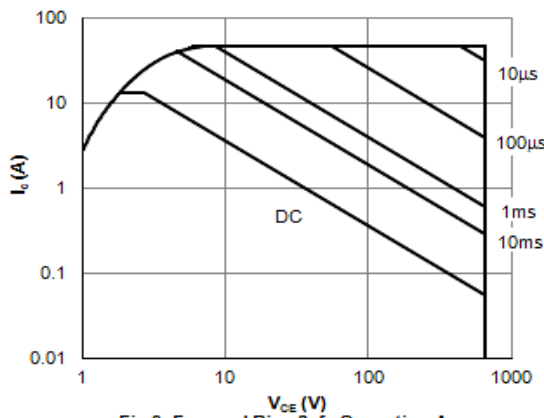


Fig 9: Forward Bias Safe Operating Area
($T_C=25^\circ\text{C}, V_{GE}=15\text{V}$)

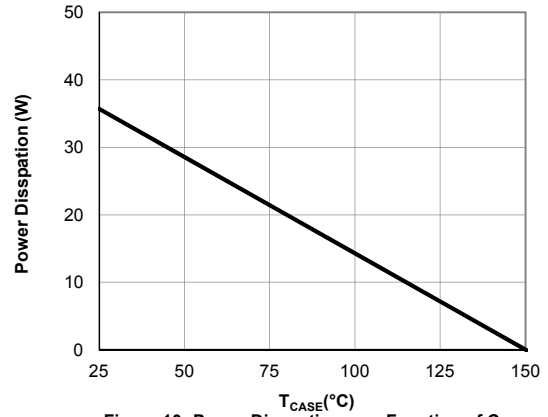


Figure 10: Power Dissipation as a Function of Case

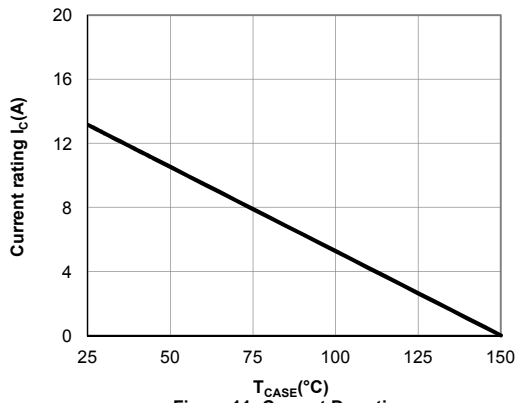


Figure 11: Current De-rating

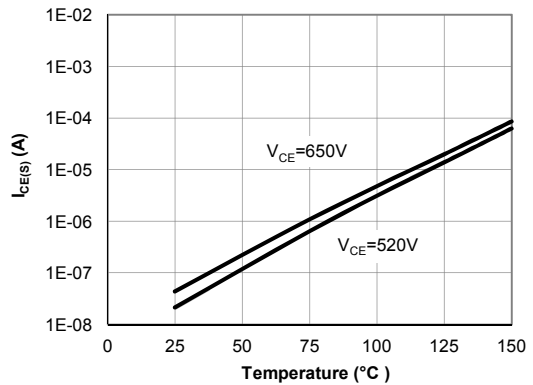
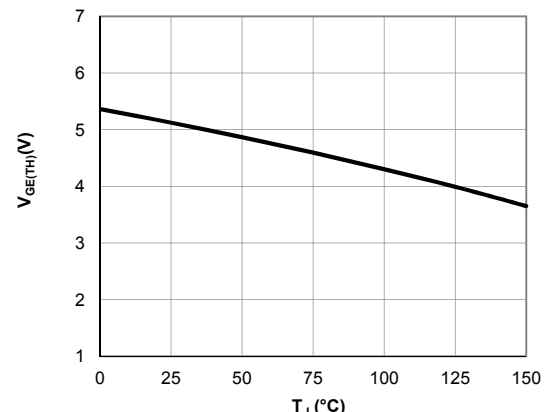
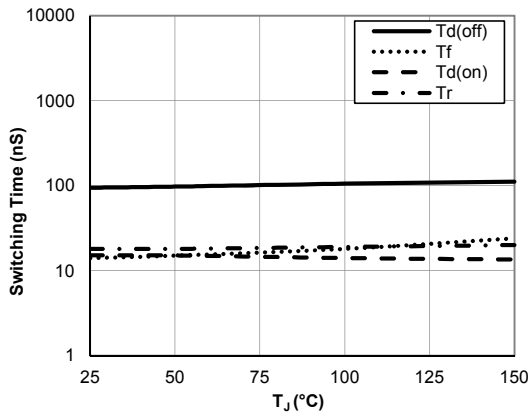
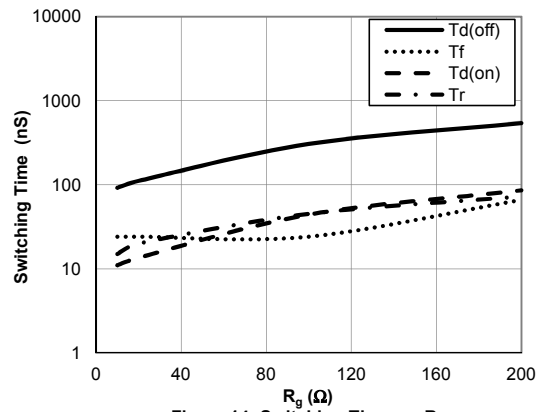
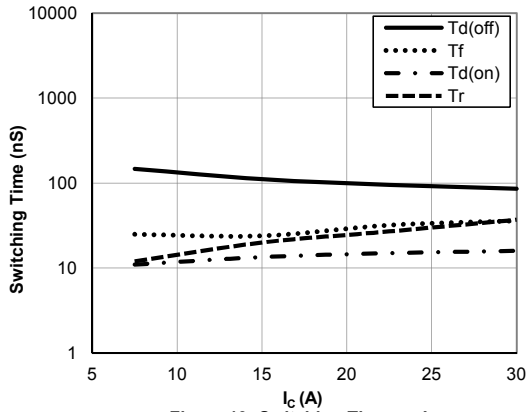


Figure 12: Diode Reverse Leakage Current vs. Junction Temperature

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

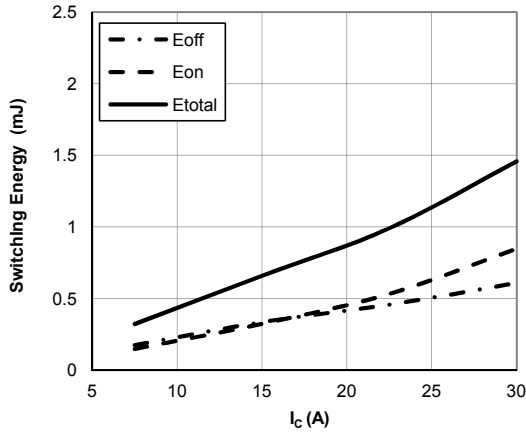


Figure 17: Switching Loss vs. I_c
($T_j=150^\circ\text{C}, V_{GE}=15\text{V}, V_{CE}=400\text{V}, R_g=20\Omega$)

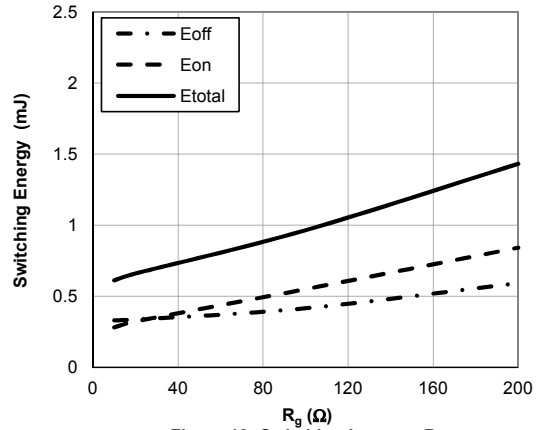


Figure 18: Switching Loss vs. R_g
($T_j=150^\circ\text{C}, V_{GE}=15\text{V}, V_{CE}=400\text{V}, I_c=15\text{A}$)

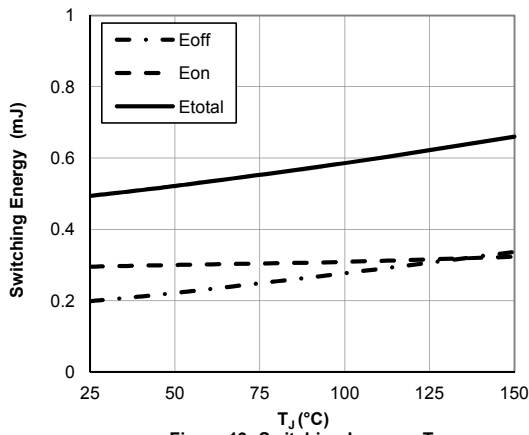


Figure 19: Switching Loss vs. T_j
($V_{GE}=15\text{V}, V_{CE}=400\text{V}, I_c=15\text{A}, R_g=20\Omega$)

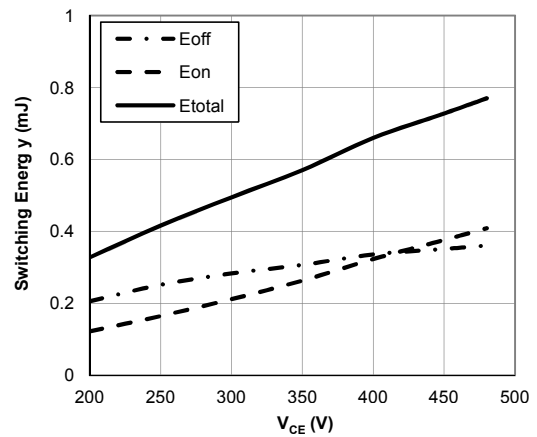


Figure 20: Switching Loss vs. V_{CE}
($T_j=150^\circ\text{C}, V_{GE}=15\text{V}, I_c=15\text{A}, R_g=20\Omega$)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

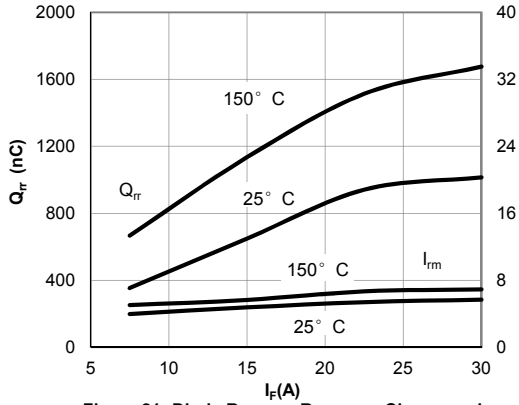


Figure 21: Diode Reverse Recovery Charge and Peak Current vs. Conduction Current
($V_{GE}=15V, V_{CE}=400V, di/dt=200A/\mu s$)

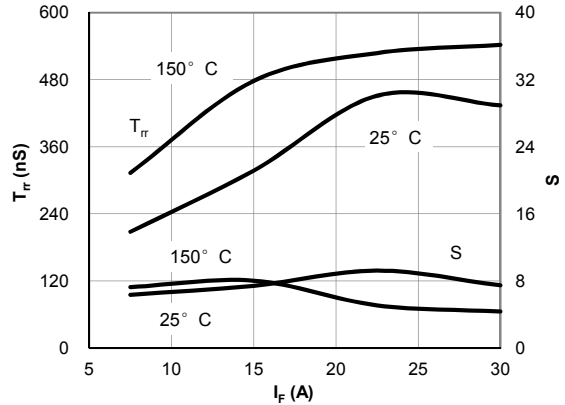


Figure 22: Diode Reverse Recovery Time and Softness Factor vs. Conduction Current
($V_{GE}=15V, V_{CE}=400V, di/dt=200A/\mu s$)

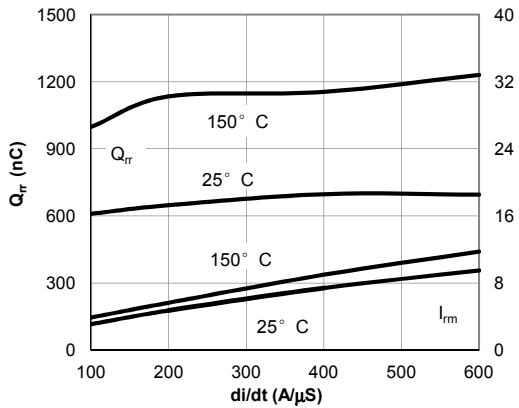


Figure 23: Diode Reverse Recovery Charge and Peak Current vs. di/dt
($V_{GE}=15V, V_{CE}=400V, I_F=15A$)

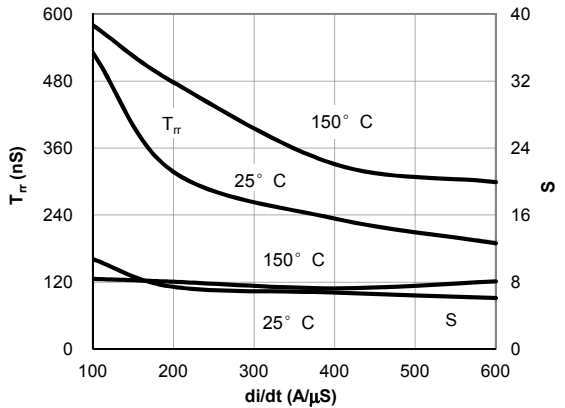


Figure 24: Diode Reverse Recovery Time and Softness Factor vs. di/dt
($V_{GE}=15V, V_{CE}=400V, I_F=15A$)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

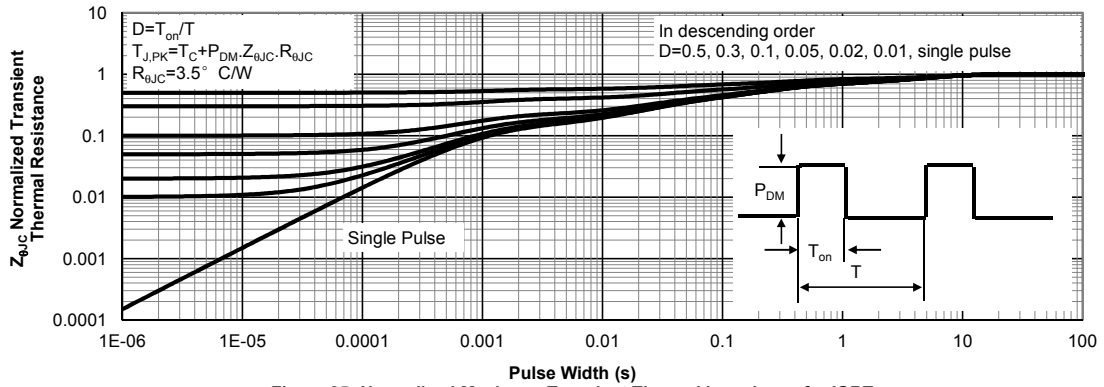


Figure 25: Normalized Maximum Transient Thermal Impedance for IGBT

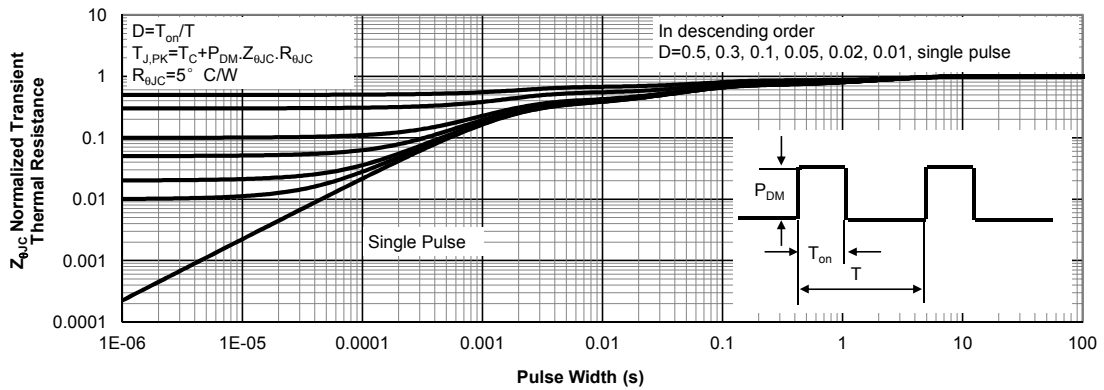


Figure 26: Normalized Maximum Transient Thermal Impedance for Diode

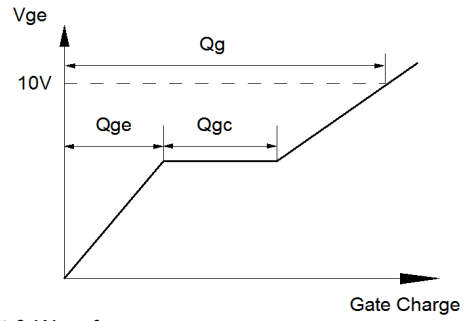
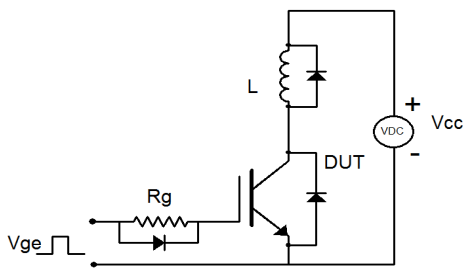


Figure A: Gate Charge Test Circuit & Waveforms

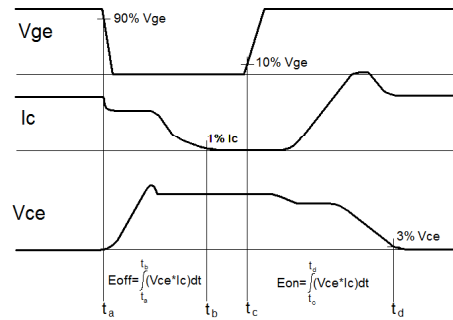
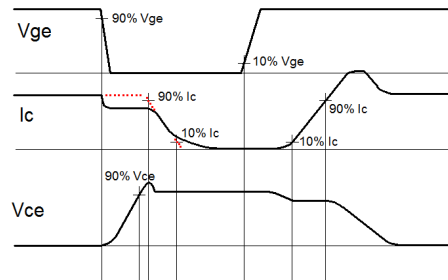
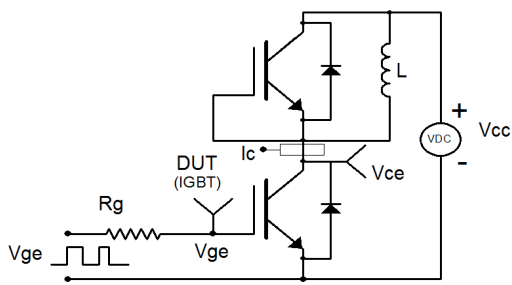


Figure B: Inductive Switching Test Circuit & Waveforms

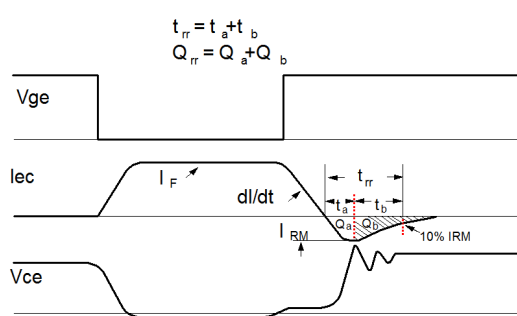
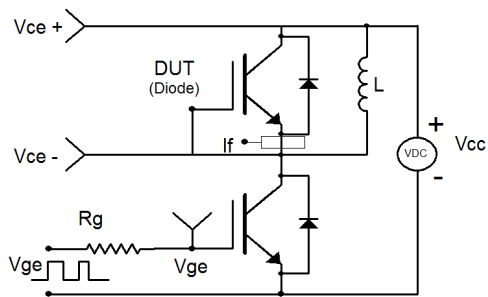


Figure C: Diode Recovery Test Circuit & Waveforms